

# Voltage comparator

NE527

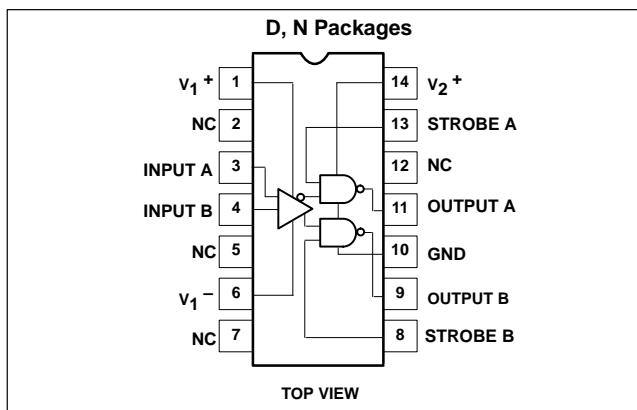
## DESCRIPTION

The NE527 is a high-speed analog voltage comparator which, for the first time, mates state-of-the-art Schottky diode technology with the conventional linear process. This allows simultaneous fabrication of high speed TTL gates with a precision linear amplifier on a single monolithic chip. The NE527 is similar in design to the Philips Semiconductors NE529 voltage comparator except that it incorporates an "Emitter-Follower" input stage for extremely low input currents. This opens the door to a whole new range of applications for analog voltage comparators.

## FEATURES

- 15ns propagation delay
- Complementary output gates
- TTL or ECL compatible outputs
- Wide common-mode and differential voltage range
- Typical gain of 5000

## PIN CONFIGURATIONS



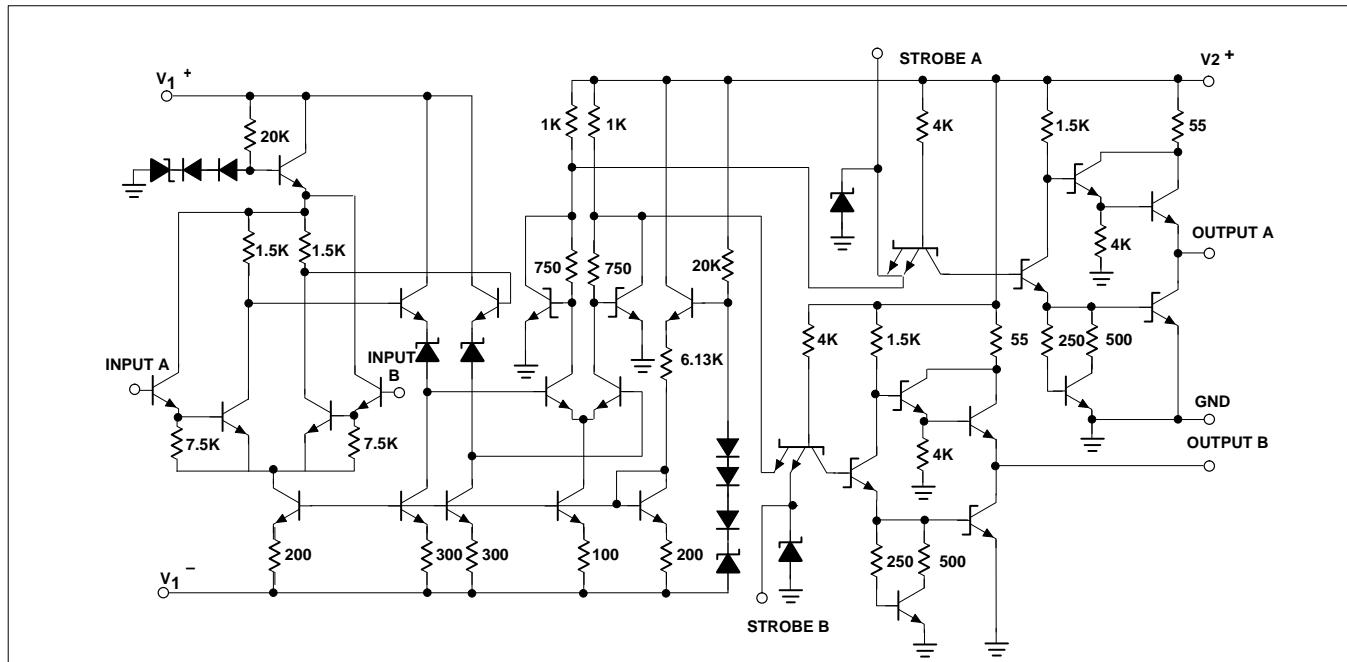
## APPLICATIONS

- A/D conversion
- ECL-to-TTL interface
- TTL-to-ECL interface
- Memory sensing
- Optical data coupling

## ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	DWG #
14-Pin Plastic Dual In-Line Package (DIP)	0 to +70°C	NE527N	0405B
14-Pin Small Outline (SO) Package	0 to +70°C	NE527D	0175D

## EQUIVALENT SCHEMATIC



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## ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
$V_{1+}$	Positive supply voltage	+15	V
$V_{1-}$	Negative supply voltage	-15	V
$V_{2+}$	Gate supply voltage	+7	V
$V_{OUT}$	Output voltage	+7	V
$V_{IN}$	Differential input voltage	$\pm 5$	V
$V_{CM}$	Input common mode voltage	$\pm 6$	V
$P_D$	Max power dissipation <sup>1</sup> 25°C ambient (still air)		
	N package	1420	mW
	D package	1040	mW
$T_A$	Operating temperature range	0 to +70	°C
$T_{STG}$	Storage temperature range	-65 to +150	°C
$T_{SOLD}$	Lead soldering temperature (10sec max)	+300	°C

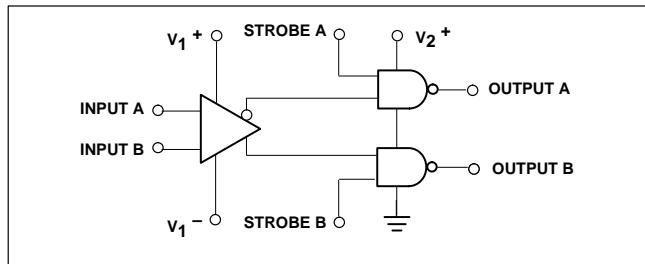
## NOTES:

1. Derate above 25°C, at the following rates:

N package 11.4mW/°C

D package 8.3mW/°C

## BLOCK DIAGRAM



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**DC ELECTRICAL CHARACTERISTICS**V<sub>1+</sub>=10V, V<sub>1-</sub>=-10V, V<sub>2+</sub>=+5.0V, unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	NE527			UNIT
			Min	Typ	Max	
<b>Input characteristics</b>						
V <sub>OS</sub>	Input offset voltage @ 25°C over temperature range				6 10	mV
I <sub>BIAS</sub>	Input bias current @ 25°C over temperature range				2 4	µA
I <sub>OS</sub>	Input offset current @ 25°C over temperature range	V <sub>IN</sub> =0V			0.75 1	µA µA
V <sub>CM</sub>	Common-mode voltage range		-5		+5	V
<b>Gate characteristics</b>						
V <sub>OUT</sub>	Output Voltage "1" State "0" State	V <sub>2+</sub> =4.75V, I <sub>SOURCE</sub> =-1mA V <sub>2+</sub> =4.75V, I <sub>SINK</sub> =10mA	2.7	3.3	0.5	V V
	Strobe inputs "0" Input current <sup>1</sup> "1" Input current @ 25°C <sup>1</sup> Over temperature range "0" Input voltage "1" Input voltage	V <sub>2+</sub> =5.25V, V <sub>STROBE</sub> =0.5V V <sub>2+</sub> =5.25V, V <sub>STROBE</sub> =2.7V V <sub>2+</sub> =5.25V, V <sub>STROBE</sub> =2.7V V <sub>2+</sub> =4.75V V <sub>2+</sub> =4.75V			-2 100 200 0.8 2.0	mA µA µA V V
I <sub>SC</sub>	Short-circuit output current	V <sub>2+</sub> =5.25V, V <sub>OUT</sub> =0V	-18		-70	mA
<b>Power supply requirements</b>						
V <sub>1+</sub> V <sub>1-</sub> V <sub>2+</sub>	Supply voltage		5 -6 4.75		10 -10 5.25	V V V
I <sub>1+</sub> I <sub>1-</sub> I <sub>2+</sub>	Supply current	V <sub>1+</sub> =10V, V <sub>1-</sub> =-10V V <sub>2+</sub> =5.25V Over temp. Over temp. Over temp.			5 10 20	mA mA mA

**NOTES:**

- See Logic Function Table.

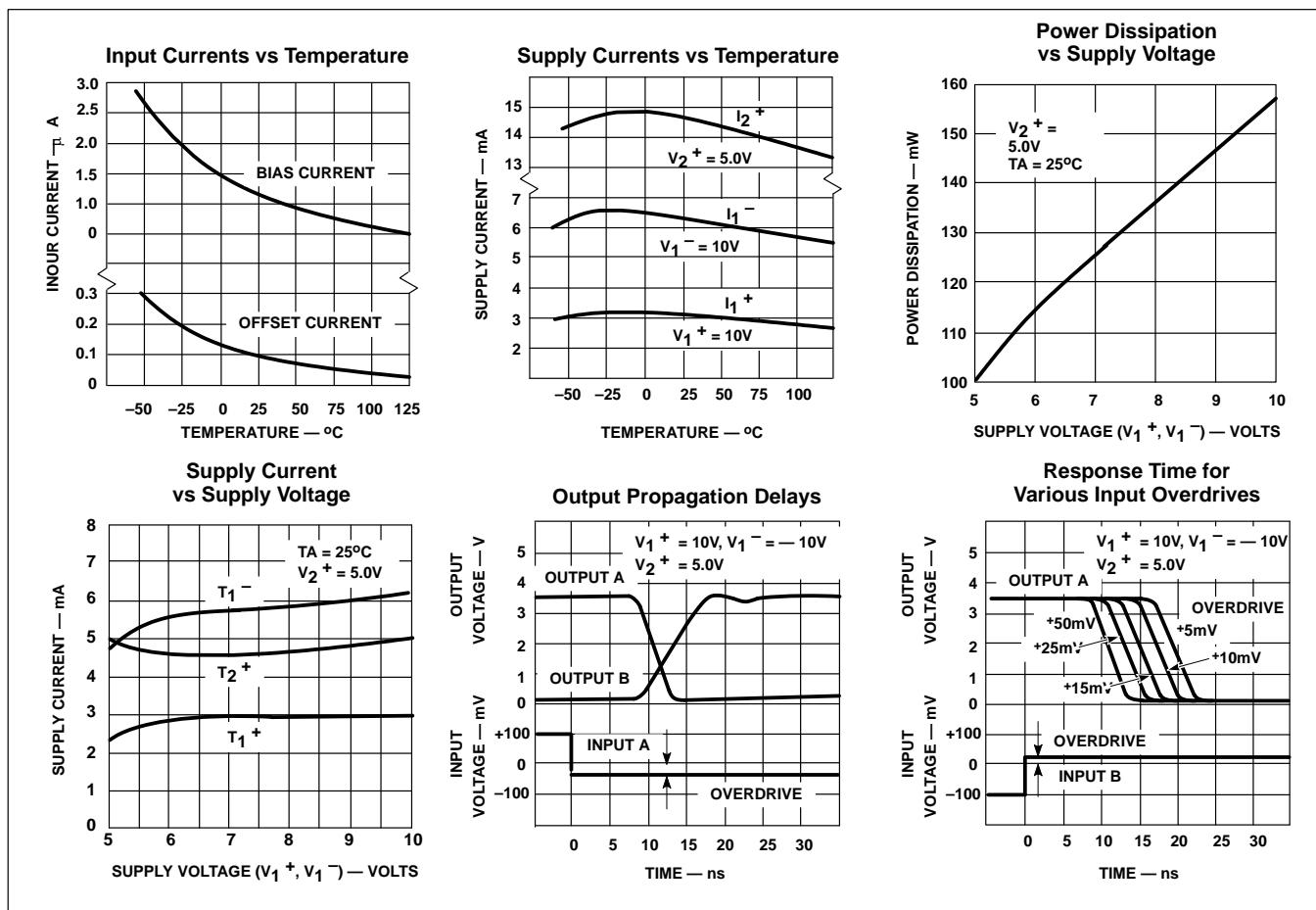
**AC ELECTRICAL CHARACTERISTICS**T<sub>A</sub>=25°C, unless otherwise specified. (See AC test circuit)

SYMBOL	PARAMETER	TEST CONDITIONS	LIMITS			UNIT
			Min	Typ	Max	
t <sub>PLH</sub> t <sub>PHL</sub>	Transient response propagation delay time Low-to-High High-to-Low	V <sub>IN</sub> =±100mV step		16 14	26 24	ns ns
	Delay between output A and B			2	5	ns
t <sub>ON</sub> t <sub>OFF</sub>	Strobe delay time Turn-on time Turn-off time			6 6		ns ns

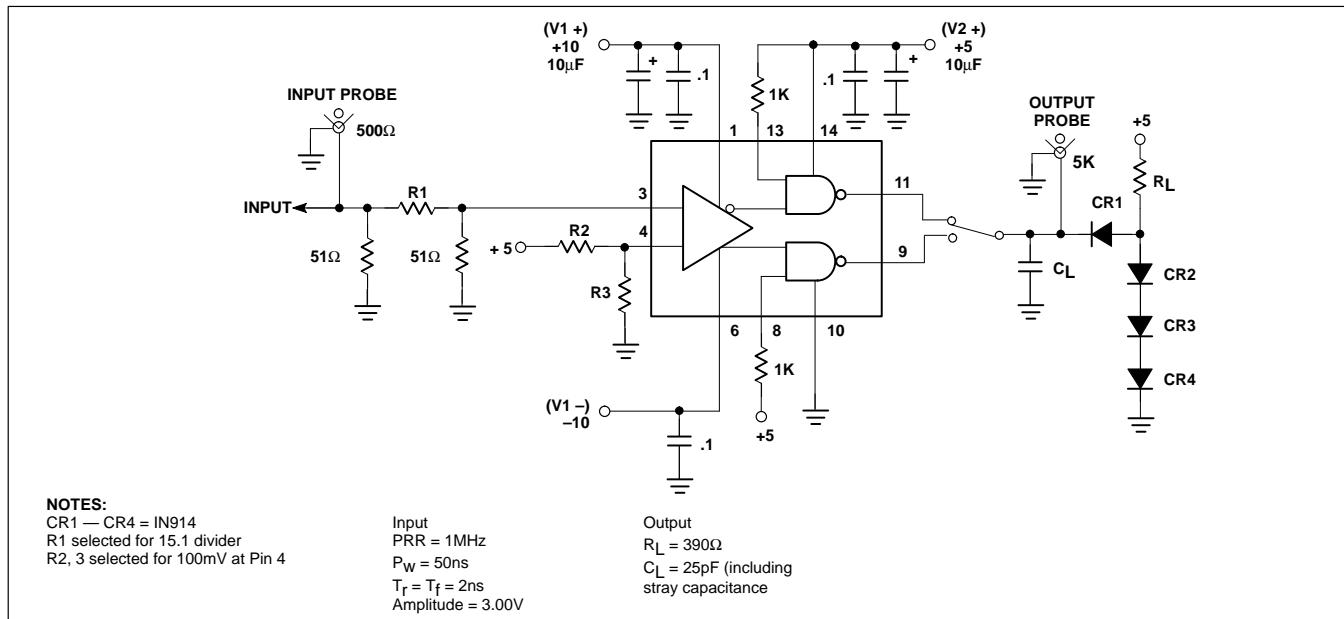
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## TYPICAL PERFORMANCE CHARACTERISTICS



## RESPONSE TIME TEST CIRCUIT



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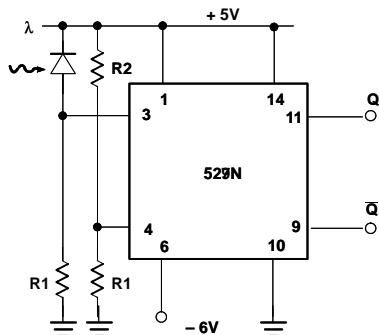
**APPLICATIONS**

One of the main features of the device is that supply voltages ( $V_{1+}$ ,  $V_{1-}$ ) need not be balanced, as in the following diagrams. For proper operation, however, negative supply ( $V_{1-}$ ) should always be at least 6V more than the ground terminal (Pin 6). Input common-mode

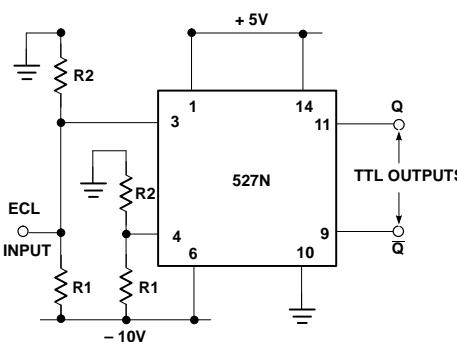
range should be limited to values of 2V less than the supply voltages ( $V_{1+}$  and  $V_{1-}$ ) up to a maximum of  $\pm 5V$  as supply voltages are increased. It is also important to note that Output A is in phase with Input A and Output B is in phase with Input B.

**LOGIC FUNCTION**

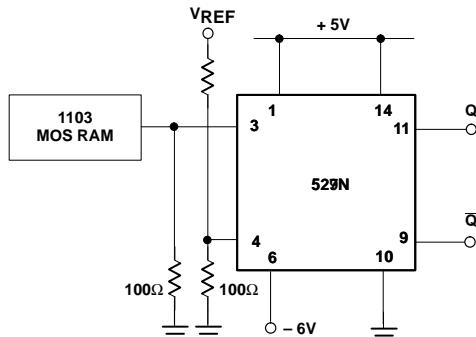
$V_{ID}$ ( $A^+$ , $B^-$ )	STROBE A	STROBE B	OUTPUT A	OUTPUT B	COMMENT
$V_{ID} \leq V_{OS}$	H	X	L	H	Read $I_{IHA}$ , $I_{ILB}$
$-V_{OS} < V_{ID} < V_{OS}$	H	H	Undefined	Undefined	
$V_{ID} \geq V_{OS}$	X	H	H	L	Read $I_{ILA}$ , $I_{IHB}$
X	L	L	H	H	

**TYPICAL APPLICATIONS**

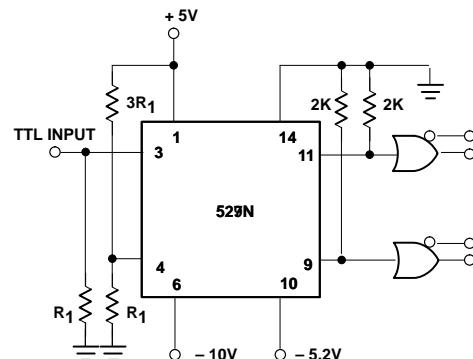
Photodiode Detector



ECL-to-TTL Interface



MOS Memory Sense AMP



TTL-to-ECL Interface